Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/681,422	VAN OOIJ ET AL.	
Examiner	Art Unit	
Michael J. Feelv	1712	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search on Palm, eDan, East	2/23/2006	MF	
Limited Class Seach on East of: 427/299,301,327,328,402,404,405, 406,407.1,409,413,419.1,419.2,419.5, 419.7,419.8	2/23/2006	MF	
Limited Class Search on East of: 428/446,447,448,450; 528/38	2/23/2006	MF	
Text Search on East (USPAT, US- PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB)	2/23/2006	MF	
Above updated	8/17/2006	MF	